



Experiment Report Form

The double page inside this form is to be filled in by all users or groups of users who have had access to beam time for measurements at the ESRF. Once completed, the original report should be sent, together with 5 reduced (A4) copies, to the User Office.

In addition, please send a copy of your file as an e-mail attachment to reports@esrf.fr, using the number of your experiment to name your file. This will enable us to process your report for the ESRF Annual Report.

Reports accompanying requests for additional beam time

If your report is to support a **new proposal**, the original report form should be sent with the new proposal form, and a copy of your report should be attached to each copy of your proposal. The Review Committees reserve the right to reject new proposals from groups who have not reported on the use of beam time allocated previously.

Reports on experiments relating to long term projects

Proposers awarded beam time for a long term project are required to submit an interim report at the end of each year, irrespective of the number of shifts of beam time they have used.

Published papers

All users must give proper credit to ESRF staff members and proper mention to ESRF facilities which were essential for the results described in any ensuing publication. Further, they are obliged to send to the Joint ESRF/ ILL library the complete reference and the abstract of all papers appearing in print, and resulting from the use of the ESRF.

Should you wish to make more general comments on the experiment, please note them on the User Evaluation Form, and send both the Report and the Evaluation Form to the User Office.

Deadlines for submission of Experimental Reports

- 1st March for experiments carried out up until June of the previous year;
- 1st September for experiments carried out up until January of the same year.

Instructions for preparing your Report

- fill in a separate form for each project or series of measurements.
- type your report, in English.
- include the reference number of the proposal to which the report refers.
- make sure that the text, tables and figures fit into the space available.
- if your work is published or is in press, you may prefer to paste in the abstract, and add full reference details. If the abstract is in a language other than English, please include an English translation.
- bear in mind that the report will be reduced to 71% of its original size. A type-face such as "Times", 14 points, with a 1.5 line spacing between lines for the text, produces a report which can be read easily.

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Results: We studied the molar-mass dependence of the structure of thin films prepared using spin-coating onto Si-wafers. In order to get detailed information about the electron density along the film normal, we performed XR measurements extending to higher angles than in our previous measurements. The XR curves of high molar mass samples (perpendicular lamellae) show Kiessig fringes related to the film thickness (Fig. 1a). In contrast, XR curves from low molar mass samples show modulated oscillations which points to density variations along the film normal (Fig. 1c). For some samples, shoulders or oscillations at high q -values are observed, indicating the presence of a very thin layer in the film (Fig. 1b). We are currently analyzing these data in terms of a box model.

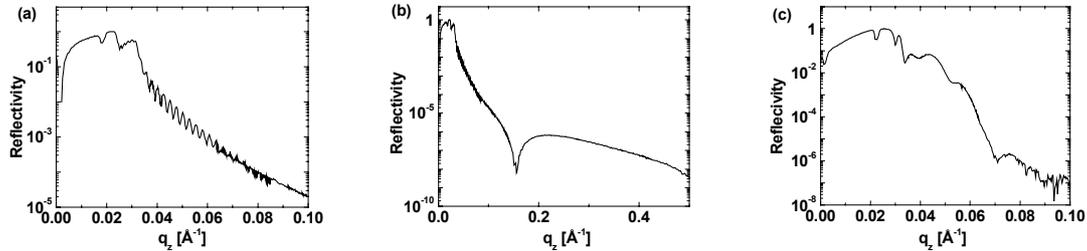


Fig. 1: XR curves of samples having (a, b) 148 kg/mol, $D_{\text{lam}} = 752 \text{ \AA}$ and a film thickness $D_{\text{film}} = 1990 \text{ \AA}$ and (c) 22.1 kg/mol, $D_{\text{lam}} = 189 \text{ \AA}$, $D_{\text{film}} = 410 \text{ \AA}$.

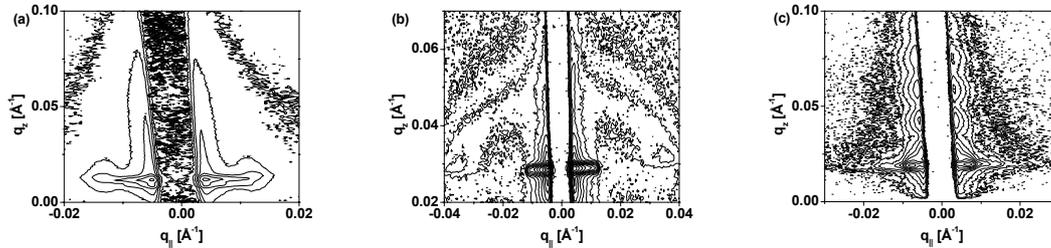


Fig. 2: 2D-GISAXS maps of spin-coated samples having (a) 91.9 kg/mol, $D_{\text{lam}} = 528 \text{ \AA}$ and $D_{\text{film}} = 1700 \text{ \AA}$ and (b) 18.3 kg/mol, $D_{\text{lam}} = 160 \text{ \AA}$ and $D_{\text{film}} = 1420 \text{ \AA}$. (c) Vapor-treated film: 183 kg/mol, $D_{\text{lam}} = 839 \text{ \AA}$ and $D_{\text{film}} = 2420 \text{ \AA}$.

GISAXS experiments provide information both in the scattering plane (q_z) and out of the scattering plane (q_{\parallel}) giving additional information about the correlated roughness oscillations between the interfaces if the lamellae are parallel to the film surface [1] and about the in-plane ordering of the films consisting of lamellae perpendicular to the film surface. We found straight out-of-plane Bragg-rods for high molar mass samples (Fig. 2a), indicating that the lamellae are perpendicular to the film surface. In contrast, for low molar mass samples, instead of Bragg-rods, a ring is observed (Fig. 2b). This is contrary to our previous observations where we did not observe scattering outside the scattering plane, also for even lower molar masses [1, 2], and might be related to the different film thicknesses studied. The ring indicates the presence of parallel and tilted lamellae.

We also performed measurements on a high molar mass sample treated by toluene vapor after spin-coating. Before vapor treatment, the GISAXS map displayed out-of-plane Bragg rods similar to the ones in Fig. 2a. During two days of vapor treatment, oscillations along the q_z -axis ($q_{\parallel} \cong 0$) develop (Fig. 2c). These oscillations are attributed to the correlated roughness of lamellar interfaces which are parallel to the film surface. Vapor treatment thus leads to substantial changes in the inner film structure, i.e. the initial perpendicular orientation is not the equilibrium structure.

- [1] C.M. Papadakis, P. Busch, F. Kremer, D.-M. Smilgies, D. Posselt, Structure of thin films of symmetric diblock copolymers and of their binary blends, studied using grazing-incidence small-angle X-ray scattering, Experimental Report of our beam time SC-696 at ESRF, August 2000.
- [2] P. Busch, D. Posselt, D.-M. Smilgies, C.M. Papadakis, submitted.
- [3] C.M. Papadakis, K. Almdal, K. Mortensen, D. Posselt, *Europhys. Lett.* **36**, 289 (1996).